FAIRCHILD SEMICONDUCTOR™

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CD4047BC
Low Power Monostable/Astable Multivibrator

General Description

The CD4047B is capable of operating in either the monostable or astable mode. It requires an external capacitor (between pins 1 and 3) and an external resistor (between pins 2 and 3) to determine the output pulse width in the monostable mode, and the output frequency in the astable mode.

Astable operation is enabled by a high level on the astable input or low level on the astable input. The output frequency (at 50% duty cycle) at Q and $\overline{Q}$ outputs is determined by the timing components. A frequency twice that of Q is available at the Oscillator Output; a 50% duty cycle is not guaranteed.

Monostable operation is obtained when the device is triggered by LOW-to-HIGH transition at + trigger input or HIGH-to-LOW transition at – trigger input. The device can be retriggered by applying a simultaneous LOW-to-HIGH transition to both the + trigger and retrigger inputs.

A high level on Reset input resets the outputs Q to LOW, $\overline{Q}$ to HIGH.

Features

- Wide supply voltage range: 3.0V to 15V
- High noise immunity: 0.45 V_{DD} (typ.)
- Low power TTL compatibility: Fan out of 2 driving 74L or 1 driving 74LS

Special Features

- Low power consumption: special CMOS oscillator configuration
- Monostable (one-shot) or astable (free-running) operation
- True and complemented buffered outputs
- Only one external R and C required

Monostable Multivibrator Features

- Positive- or negative-edge trigger
- Output pulse width independent of trigger pulse duration
- Retriggerable option for pulse width expansion
- Long pulse widths possible using small RC components by means of external counter provision
- Fast recovery time essentially independent of pulse width
- Pulse-width accuracy maintained at duty cycles approaching 100%

Astable Multivibrator Features

- Free-running or gatable operating modes
- 50% duty cycle
- Oscillator output available
- Good astable frequency stability

  typical= ±2% + 0.03%/°C @ 100 kHz

  frequency= ±0.5% + 0.015%/°C @ 10 kHz

  deviation (circuits trimmed to frequency V_{DD} = 10V ±10%)

Applications

- Frequency discriminators
- Timing circuits
- Time-delay applications
- Envelope detection
- Frequency multiplication
- Frequency division

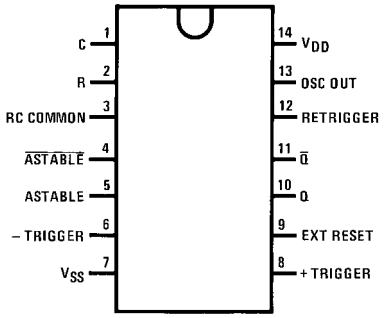
Ordering Code:

Order Number	Package Number	Package Description
CD4047BCM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
CD4047BCN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram

Pin Assignments for SOIC and DIP



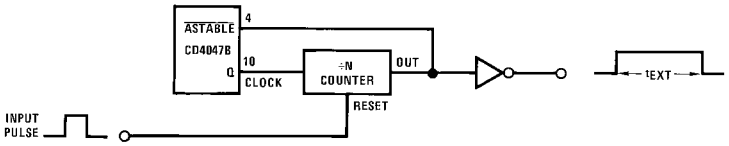
Top View

Function Table

Function	Terminal Connections			Output Pulse From	Typical Output Period or Pulse Width
	To V_{DD}	To V_{SS}	Input Pulse To		
Astable Multivibrator					
Free-Running	4, 5, 6, 14	7, 8, 9, 12		10, 11, 13	$t_A(10, 11) = 4.40$ RC
True Gating	4, 6, 14	7, 8, 9, 12	5	10, 11, 13	$t_A(13) = 2.20$ RC
Complement Gating	6, 14	5, 7, 8, 9, 12	4	10, 11, 13	
Monostable Multivibrator					
Positive-Edge Trigger	4, 14	5, 6, 7, 9, 12	8	10, 11	
Negative-Edge Trigger	4, 8, 14	5, 7, 9, 12	6	10, 11	$t_M(10, 11) = 2.48$ RC
Retriggerable	4, 14	5, 6, 7, 9	8, 12	10, 11	
External Countdown (Note 1)	14	5, 6, 7, 8, 9, 12	Figure 1	Figure 1	Figure 1

Note 1: External resistor between terminals 2 and 3. External capacitor between terminals 1 and 3.

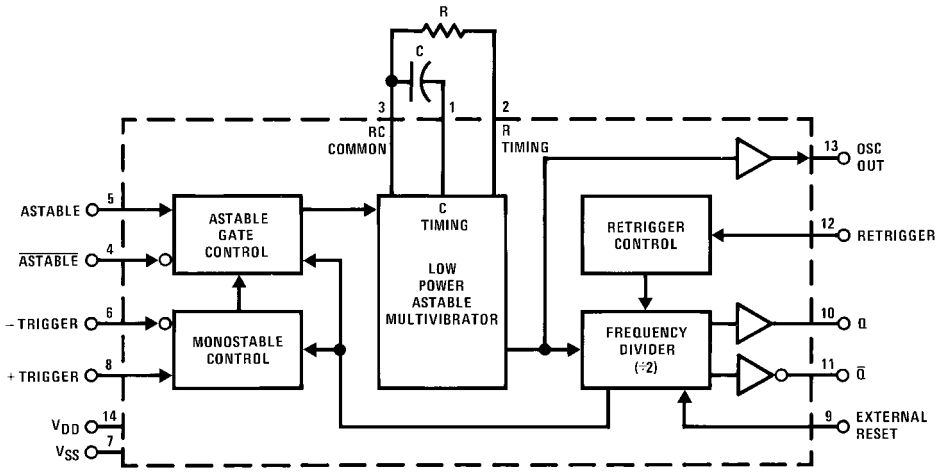
Typical Implementation of External Countdown Option



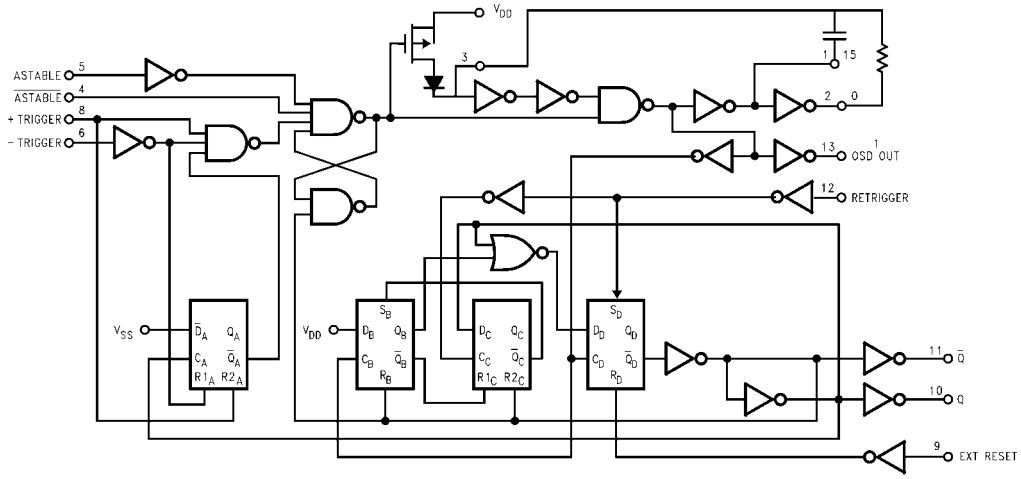
$t_{EXT} = (N - 1)\, t_A + (t_M + t_A/2)$

FIGURE 1.

Block Diagram



Logic Diagram



*Special input protection circuit to permit larger input-voltage swings.

Absolute Maximum Ratings (Note 2)

(Note 3)

DC Supply Voltage (V_{DD})	−0.5V to +18V_{DC}
Input Voltage (V_{IN})	−0.5V to V_{DD} +0.5V_{DC}
Storage Temperature Range (T_S)	−65°C to +150°C
Power Dissipation (P_D)	
Dual-In-Line	700 mW
Small Outline	500 mW
Lead Temperature (T_L)	
(Soldering, 10 seconds)	260°C

Recommended Operating Conditions (Note 3)

DC Supply Voltage (V_{DD})	3V to 15V_{DC}
Input Voltage (V_{IN})	0 to V_{DD} V_{DC}
Operating Temperature Range (T_A)	−55°C to +125°C

Note 2: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Recommended Operating Conditions" and "Electrical Characteristics" provides conditions for actual device operation.

Note 3: V_{SS} = 0V unless otherwise specified.

DC Electrical Characteristics (Note 3)

Symbol	Parameter	Conditions	−55°C		25°C			125°C		Units
			Min	Max	Min	Typ	Max	Min	Max	
I_{DD}	Quiescent Device Current	V_{DD} = 5V		5			5		150	
		V_{DD} = 10V		10			10		300	µA
		V_{DD} = 15V		20			20		600	
V_{OL}	LOW Level Output Voltage	$\|I_O\|$ < 1 µA								
		V_{DD} = 5V		0.05		0	0.05		0.05	
		V_{DD} = 10V		0.05		0	0.05		0.05	V
		V_{DD} = 15V		0.05		0	0.05		0.05	
V_{OH}	HIGH Level Output Voltage	$\|I_O\|$ < 1 µA								
		V_{DD} = 5V	4.95		4.95	5		4.95		
		V_{DD} = 10V	9.95		9.95	10		9.95		V
		V_{DD} = 15V	14.95		14.95	15		14.95		
V_{IL}	LOW Level Input Voltage	V_{DD} = 5V, V_O = 0.5V or 4.5V		1.5		2.25	1.5		1.5	
		V_{DD} = 10V, V_O = 1V or 9V		3.0		4.5	3.0		3.0	V
		V_{DD} = 15V, V_O = 1.5V or 13.5V		4.0		6.75	4.0		4.0	
V_{IH}	HIGH Level Input Voltage	V_{DD} = 5V, V_O = 0.5V or 4.5V	3.5		3.5	2.75		3.5		
		V_{DD} = 10V, V_O = 1V or 9V	7.0		7.0	5.5		7.0		V
		V_{DD} = 15V, V_O = 1.5V or 13.5V	11.0		11.0	8.25		11.0		
I_{OL}	LOW Level Output Current	V_{DD} = 5V, V_O = 0.4V	0.64		0.51	0.88		0.36		
	(Note 4)	V_{DD} = 10V, V_O = 0.5V	1.6		1.3	2.25		0.9		mA
		V_{DD} = 15V, V_O = 1.5V	4.2		3.4	8.8		2.4		
I_{OH}	HIGH Level Output Current	V_{DD} = 5V, V_O = 4.6V	−0.64		−0.51	−0.88		−0.36		
	(Note 4)	V_{DD} = 10V, V_O = 9.5V	−1.6		−1.3	−2.25		−0.9		mA
		V_{DD} = 15V, V_O = 13.5V	−4.2		−3.4	−8.8		−2.4		
I_{IN}	Input Current	V_{DD} = 15V, V_{IN} = 0V		−0.1		-10^{-5}	−0.1		−1.0	µA
		V_{DD} = 15V, V_{IN} = 15V		0.1		10^{-5}	0.1		1.0	

Note 4: I_{OH} and I_{OL} are tested one output at a time.

AC Electrical Characteristics (Note 5)

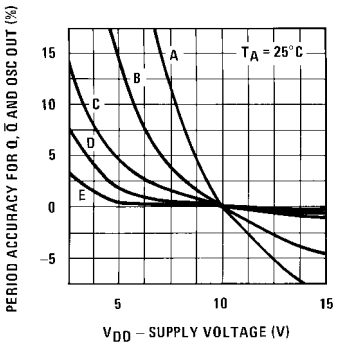
$T_A = 25°C$, $C_L = 50$ pF, $R_L = 200$k, input $t_r = t_f = 20$ ns, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Units
t_{PHL}, t_{PLH}	Propagation Delay Time Astable,	$V_{DD} = 5V$		200	400	
	$\overline{\text{Astable}}$ to Osc Out	$V_{DD} = 10V$		100	200	ns
		$V_{DD} = 15V$		80	160	
t_{PHL}, t_{PLH}	Astable, $\overline{\text{Astable}}$ to Q, $\overline{Q}$	$V_{DD} = 5V$		550	900	
		$V_{DD} = 10V$		250	500	ns
		$V_{DD} = 15V$		200	400	
t_{PHL}, t_{PLH}	+ Trigger, − Trigger to $\overline{Q}$	$V_{DD} = 5V$		700	1200	
		$V_{DD} = 10V$		300	600	ns
		$V_{DD} = 15V$		240	480	
t_{PHL}, t_{PLH}	+ Trigger, Retrigger to $\overline{Q}$	$V_{DD} = 5V$		300	600	
		$V_{DD} = 10V$		175	300	ns
		$V_{DD} = 15V$		150	250	
t_{PHL}, t_{PLH}	Reset to Q, $\overline{Q}$	$V_{DD} = 5V$		300	600	
		$V_{DD} = 10V$		125	250	ns
		$V_{DD} = 15V$		100	200	
t_{THL}, t_{TLH}	Transition Time Q, $\overline{Q}$, Osc Out	$V_{DD} = 5V$		100	200	
		$V_{DD} = 10V$		50	100	ns
		$V_{DD} = 15V$		40	80	
t_{WL}, t_{WH}	Minimum Input Pulse Duration	Any Input				
		$V_{DD} = 5V$		500	1000	
		$V_{DD} = 10V$		200	400	ns
		$V_{DD} = 15V$		160	320	
t_{RCL}, t_{FCL}	+ Trigger, Retrigger, Rise and	$V_{DD} = 5V$			15	
	Fall Time	$V_{DD} = 10V$			5	µs
		$V_{DD} = 15V$			5	
C_{IN}	Average Input Capacitance	Any Input		5	7.5	pF

Note 5: AC Parameters are guaranteed by DC correlated testing.

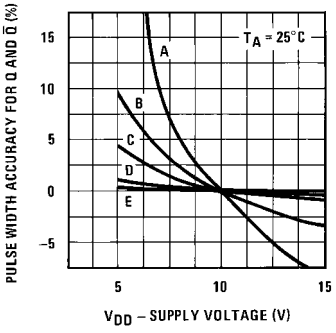
Typical Performance Characteristics

Typical Q, $\overline{Q}$, Osc Out Period Accuracy vs Supply Voltage (Astable Mode Operation)



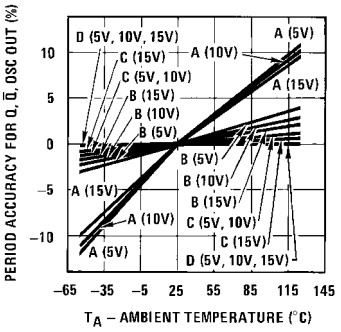
	$f_Q, \overline{Q}$	R	C
A	1000 kHz	22k	10 pF
B	100 kHz	22k	100 pF
C	10 kHz	220k	100 pF
D	1 kHz	220k	1000 pF
E	100 Hz	2.2M	1000 pF

Typical Q, $\overline{Q}$, Pulse Width Accuracy vs Supply Voltage Monostable Mode Operation



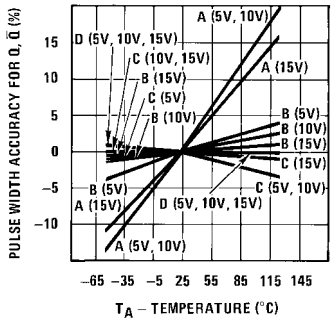
	t_M	R	C
A	2 µs	22k	10 pF
B	7 µs	22k	100 pF
C	60 µs	220k	100 pF
D	550 µs	220k	1000 pF
E	5.5 ms	2.2M	1000 pF

Typical Q, $\overline{Q}$ and Osc Out Period Accuracy vs Temperature Astable Mode Operation



	$f_Q, \overline{Q}$	R	C
A	1000 kHz	22k	10 pF
B	100 kHz	22k	100 pF
C	10 kHz	220k	100 pF
D	1 kHz	220k	1000 pF

Typical Q and $\overline{Q}$ Pulse Width Accuracy vs Temperature Monostable Mode Operation



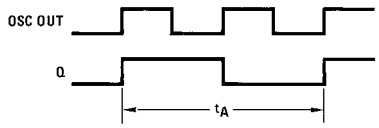
	t_M	R	C
A	2 µs	22k	10 pF
B	7 µs	22k	100 pF
C	60 µs	220k	100 pF
D	550 µs	220k	1000 pF

Note: Minimum Value of R: 10 K Ω
Maximum Value of R: 1 Meg Ω
Minimum Value of C for Astable Mode: 100 pF
Minimum Value of C for Monostable Mode: 1000 pF

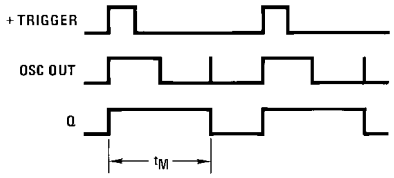
Typical Performance Characteristics (Continued)

Timing Diagrams

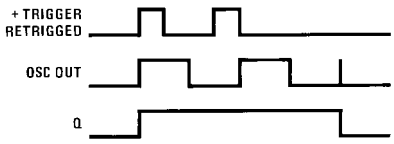
Astable Mode



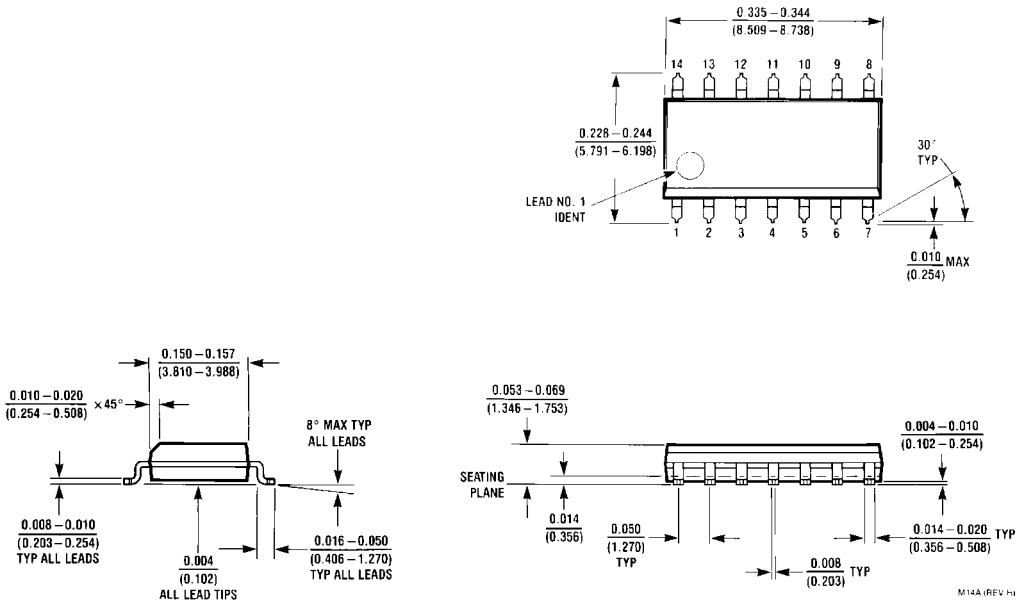
Monostable Mode



Retrigger Mode

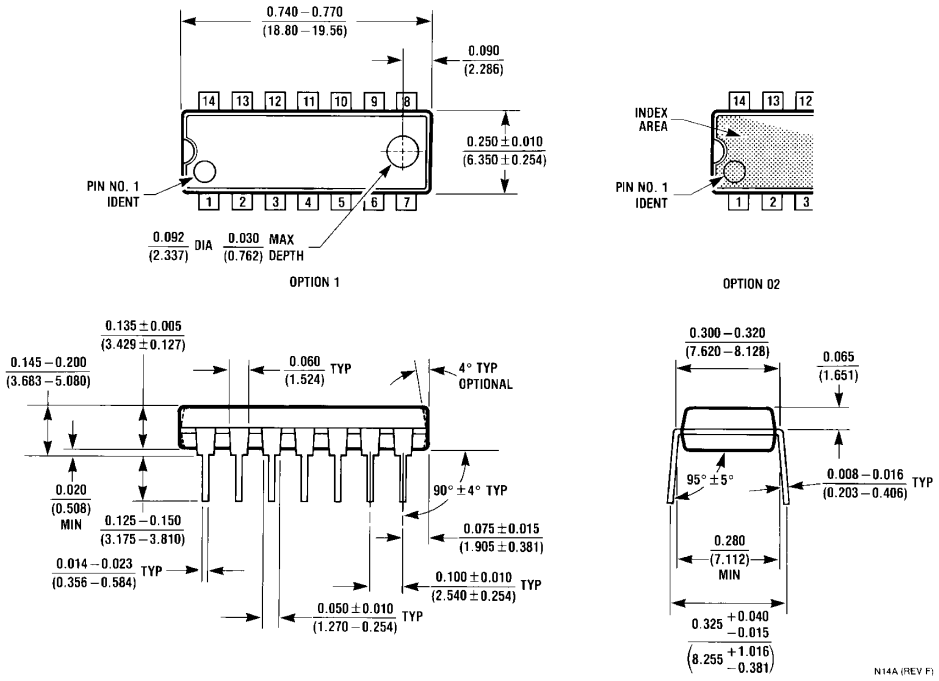


Physical Dimensions inches (millimeters) unless otherwise noted



14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
Package Number M14A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N14A

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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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